ACE93C46
Three-wire Serial EEPROM

ACE *Technology*

Description

The ACE93C46 provides 1024 bits of serial electrically erasable programmable read only memory (EEPROM) organized as 64 words of 16 bits each, when the ORG pin is connected to VCC and 128 words of 8 bits each when it is tied to ground. The ACE93C46 is available in space-saving 8-lead PDIP, 8-lead TSSOP and 8-lead JEDEC SOIC packages. The ACE93C46 is enabled through the Chip Select pin (CS), and accessed via a 3-wire serial interface consisting of Data Input (DI), Data Output (DO), and Shift Clock (SK). Upon receiving a Read instruction at DI, the address is decoded and the data is clocked out serially on the data output pin DO. The WRITE cycle is completely self-timed and no separate erase cycle is required before write. The Write cycle is only enabled when it is in the Erase/Write Enable state. When CS is brought "high" following the initiation of a write cycle, the DO pin outputs the Ready/Busy status.

Features

- Low-voltage operation – 1.8 (VCC=1.8 to 5.5V)
- Three-wire serial Interface
- 2MHz clock rate(5V) compatibility
- Self-timed write cycle (5 ms max)
- High-reliability – Endurance: 1 Million write cycles
                    Data retention: 100 Years
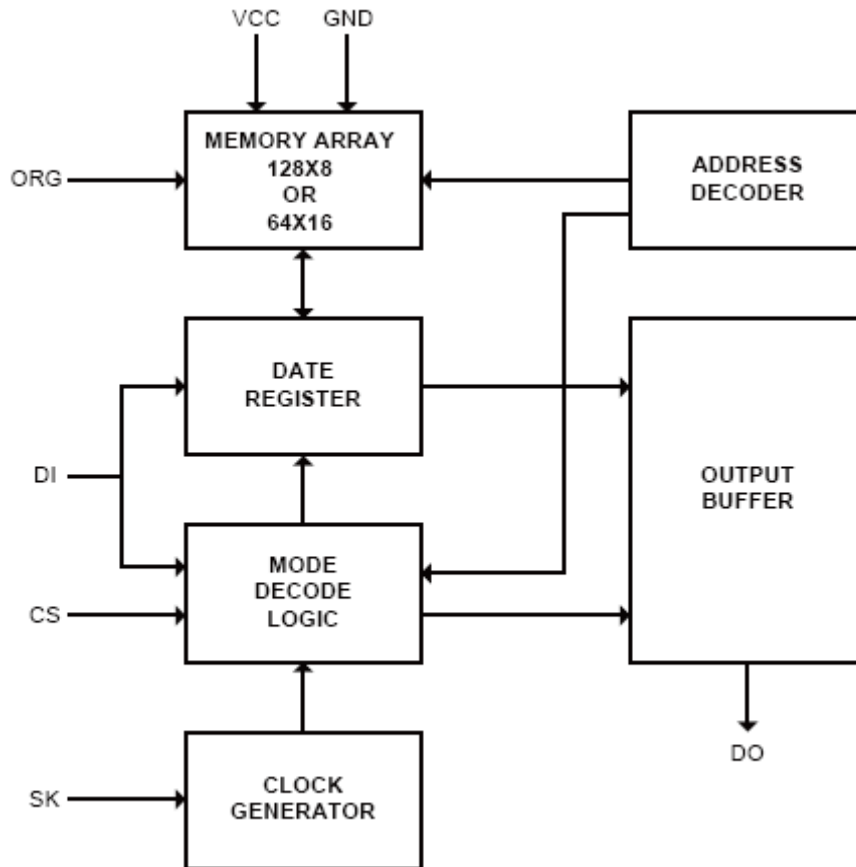- 8-lead PDIP, SOP-8, TSSOP-8 Packages

Packaging Type

DIP-8   SOP-8   TSSOP-8
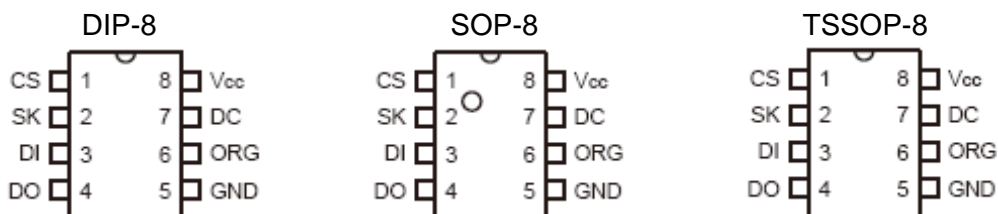
Pin Configurations

Pin Name	Function
CS	Chip select
SK	Serial Data Clock
DI	Serial Data Input
DO	Serial Data Output
GND	Ground
Vcc	Power Supply
ORG	Internal Organization
DC	Don't Connect

VER 1.2   1

ACE93C46
Three-wire Serial EEPROM

Block Diagram

Note: When the ORG pin is connected to VCC, the "x 16" organization is selected. When it is connected to ground, the "x 8" organization is selected. If the ORG pin is left unconnected and the application does not load the input beyond the capability of the internal 1 Meg ohm pullup, then the "x 16" organization is selected.
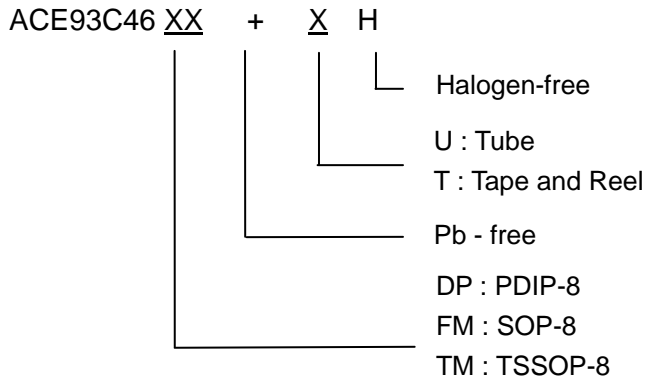
Absolute Maximum Ratings

DC Supply Voltage	-0.3 to 6.5V
Input / Output Voltage	GND -0.3 to Vcc 0.3V
Operating Ambient Temperature	-40 to 85℃
Storage Temperature	-65 to 150℃

*Notice: Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to this device. These are stress ratings only. Functional operation of this device at these or any other conditions above those indicated in the operational sections of this specification is not implied or intended. Exposure to the absolute maximum rating conditions for extended periods may affect device reliability.

ACE *Technology*

ACE93C46
Three-wire Serial EEPROM

Ordering information

Selection Guide

ACE93C46 <u>XX</u> + <u>X</u> H

                                                               Halogen-free

                                       U : Tube

                                       T : Tape and Reel

                      Pb - free

                      DP : PDIP-8

                      FM : SOP-8

                      TM : TSSOP-8

Pin Capacitance

Applicable over recommended operating range from T_A=25℃, f=1.0MHz,VCC=+1.8V (unless otherwise noted)

Test Conditions	Symbol	Max	Unit	Conditions
Output Capacitance (DO)	COUT	5	pF	VOUT=0V
Input Capacitance (CS, SK, DI)	CIN	5	pF	VIN=0V

DC Characteristics

Applicable over recommended operating range from: T_A = -40℃ to +85℃, V_{CC} = +1.8V to +5.5V, (unless otherwise noted).

Symbol	Parameter	Test Condition	Min	Typ	Max	Units
V_{CC1}	Supply Voltage		1.8		5.5	V
V_{CC2}	Supply Voltage		2.7		5.5	V
V_{CC3}	Supply Voltage		4.5		5.5	V
I_{CC1}	Supply Current	V_{CC} = 5.0V, Read at 1.0MHz		0.2	2.0	mA
		Write at 1.0MHz		0.9	3.0	
I_{SB1}	Standby Current	V_{CC} = 1.8V, CS=0V			1.0	μA
I_{SB2}	Standby Current	V_{CC} = 2.7V, CS=0V			1.0	μA
I_{SB3}	Standby Current	V_{CC} = 5.0V, CS=0V			1.0	μA
$I_{LI(1)}$	Input Leakage	V_{IN} = 0 to V_{CC}		0.1	1.0	μA
$I_{LI(2)}$	Input Leakage	V_{IN} = 0 to V_{CC}		2.0	3.0	μA
I_{OL}	Output Leakage	V_{IN} = 0 to V_{CC}		0.1	1.0	μA
$V_{IL1(3)}$	Input Low Voltage	2.7V ≦ Vcc ≦ 5.5V	-0.3		0.8	V
$V_{IH1(3)}$	Input High Voltage	2.7V ≦ Vcc ≦ 5.5V	2.0		Vcc+0.3	V

ACE93C46
Three-wire Serial EEPROM

ACE Technology

Symbol	Parameter	Test Condition	Min	Typ	Max	Units
V$_{IL2(3)}$	Input Low Voltage	1.8V≦Vcc≦2.7V	-0.3		Vcc+0.3	V
V$_{IH2(3)}$	Input High Voltage	1.8V≦Vcc≦2.7V	Vcc*0.7		Vcc+0.3	V
V$_{OL1}$	Output Low Voltage	2.7V≦Vcc≦5.5V			0.4	V
V$_{OH1}$	Output High Voltage	IOL=2.1mA IOH=-0.4mA	2.4			
V$_{OL2}$	Output Low Voltage	1.8V≦Vcc≦2.7V			0.2	V
V$_{OH2}$	Output High Voltage	IOL=0.15mA IOH=-100uA	Vcc-0.2			

Note: 1. DI.CS. SK input pin

2. ORG input pin

3. VIL min and VIH max are reference only and are not tested.

Applicable over recommended operating range from: T$_A$ = -40℃ to +85℃, V$_{CC}$ = +1.8V to +5.5V, CL=1TTL Gate and 100pF (unless otherwise noted).

Symbol	Parameter	Test Condition		Min	Typ	Max	Units
fsx	SK Clock Frequency	4.5≦Vcc≦5.5v		0		2	MHz
		2.7≦Vcc≦5.5V		0		1	
		1.8V≦Vcc≦5.5V		0		0.25	
tskh	SK High Time	4.5≦Vcc≦5.5v		250			ns
		2.7≦Vcc≦5.5V		250			
		1.8V≦Vcc≦5.5V		1000			
tskl	SK Low Time	4.5≦Vcc≦5.5v		250			ns
		2.7≦Vcc≦5.5V		250			
		1.8V≦Vcc≦5.5V		1000			
tcs	Minimum CS Low Time	4.5≦Vcc≦5.5v		250			ns
		2.7≦Vcc≦5.5V		250			
		1.8V≦Vcc≦5.5V		1000			
tcss	CS Setup Time	Relative to SK	4.5≦Vcc≦5.5v	50			ns
			2.7≦Vcc≦5.5V	50			
			1.8V≦Vcc≦5.5V	200			
tdis	DI Setup Time	Relative to SK	4.5≦Vcc≦5.5v	100			ns
			2.7≦Vcc≦5.5V	100			
			1.8V≦Vcc≦5.5V	400			
tcsh	CS Hold Time	Relative to SK		0			ns

ACE93C46
Three-wire Serial EEPROM

ACE *Technology*

Symbol	Parameter	Test Condition		Min	Typ	Max	Units
tdih	DI Hold Time	Relative to SK	$4.5 \leq Vcc \leq 5.5v$	100			ns
			$2.7 \leq Vcc \leq 5.5V$	100			
			$1.8V \leq Vcc \leq 5.5V$	400			
tpd1	Output Delay to "1"	AC Test	$4.5 \leq Vcc \leq 5.5v$			250	ns
			$2.7 \leq Vcc \leq 5.5V$			250	
			$1.8V \leq Vcc \leq 5.5V$			1000	
tpd0	Output Delay to "0"	AC Test	$4.5 \leq Vcc \leq 5.5v$			250	ns
			$2.7 \leq Vcc \leq 5.5V$			250	
			$1.8V \leq Vcc \leq 5.5V$			1000	
tsv	CS to Status Valid	AC Test	$4.5 \leq Vcc \leq 5.5v$			250	ns
			$2.7 \leq Vcc \leq 5.5V$			250	
			$1.8V \leq Vcc \leq 5.5V$			1000	
tdf	CS to DO in High Impedance	AC Test CS=VIL	$4.5 \leq Vcc \leq 5.5v$			100	ns
			$2.7 \leq Vcc \leq 5.5V$			100	
			$1.8V \leq Vcc \leq 5.5V$			400	
twp	Write Cycle Time				1.5	5	ms
Endurance[1]	5.0V, 25℃			1M			Write Cycle

Note: 1. This parameter is characterized and is not 100% tested.

Functional Description

The ACE93C46 is accessed via a simple and versatile three-wire serial communication interface. Device operation is controlled by seven instructions issued by the host processor. A valid instruction starts with a rising edge of CS and consists of a start bit (logic"1") followed by the appropriate op code and the desired memory address location.

Instruction Set for the ACE93C46

Instruction	SB	OP Code	Address		Data		Comments
			*8	*16	*8	*16	
READ	1	10	A_6-A_0	A_5-A_0			Read data stored in memory, at specified address
EWEN	1	00	11XXXXX	11XXXX			Write enable must precede all programming modes
REASE	1	11	A_6-A_0	A_5-A_0			Erase memory location An-A0
WRITE	1	01	A_6-A_0	A_5-A_0	D_7-D_0	D_{15}-D_0	Writes memory location An-A0
ERAL	1	00	10XXXXX	10XXXX			Erases all memory locations. Valid only at VCC=4.5V to 5.5V
WRAL	1	00	01XXXXX	01XXXX	D_7-D_0	D_{15}-D_0	Writes all memory locations. Valid

								only at VCC=4.5V to 5.5V
EWDS	1	00	00XXXXX	00XXXX				Disables all programming instructions

Notes: The X's in the address field represent don't care values and must be clocked.

READ (READ):

The Read (READ) instruction contains the address code for the memory location to be read. After the instruction and address are decoded, data from the selected memory location is available at the serial output pin DO. Output data changes are synchronized with the rising edges of serial clock SK. It should be noted that a dummy bit (logic "0") precedes the 8- or 16-bit data output string.

ERASE/WRITE (EWEN):

To assure data integrity, the part automatically goes into the Erase/Write Disable (EWDS) state when power is first applied. An Erase/Write Enable(EWEN) instruction must be executed first before any programming instructions can be carried out. Please note that once in the EWEN state, programming remains enabled until an EWDS instruction is executed or VCC power is removed from the part.

ERASE (ERASE):

The Erase (ERASE) instruction programs all bits in the specified memory location to the logical "1" state. The self-timed erase cycle starts once the ERASE instruction and address are decoded. The DO pin outputs the Ready/Busy status of the part if CS is brought high after being kept low for a minimum of 250 ns (TCS). A logic "1" at pin DO indicates that the selected memory location has been erased, and the part is ready for another instruction.

WRITE (WRITE):

The Write (WRITE) instruction contains the 8 or 16 bits of data to be written into the specified memory location. The self-timed programming cycle, tWP, starts after the last bit of data is received at serial data input pin DI. The DO pin outputs the Ready/Busy status of the part if CS is brought high after being kept low for a minimum of 250 ns (TCS). A logic "0" at DO indicates that programming is still in progress. A logic "1" indicates that the memory location at the specified address has been written with the data pattern contained in the instruction and the part is ready for further instructions. A Ready/Busy status cannot be obtained if the CS is brought high after the end of the selftimed programming cycle, TWP.

ERASE ALL (ERAL):

The Erase All (ERAL) instruction programs every bit in the memory array to the logic "1" state and is primarily used for testing purposes. The DO pin outputs the Ready/Busy status of the part if CS is brought high after being kept low for a minimum of 250 ns (TCS). The ERAL instruction is valid only at VCC = 5.0V ± 10%.

WRITE ALL (WRAL):

The Write All (WRAL) instruction programs all memory locations with the data patterns specified in the instruction. The DO pin outputs the Ready/Busy status of the part if CS is brought high after being kept low for a minimum of 250ns (TCS). The WRAL instruction is valid only at VCC = 5.0V ± 10%.

ACE *Technology*

ERASE/WRITE DISABLE (EWDS):

To protect against accidental data disturb, the Erase/Write Disable (EWDS) instruction disables all programming modes and should be executed after all programming operations. The operation of the Read instruction is independent of both the EWEN and EWDS instructions and can be executed at any time.

Timing Diagrams
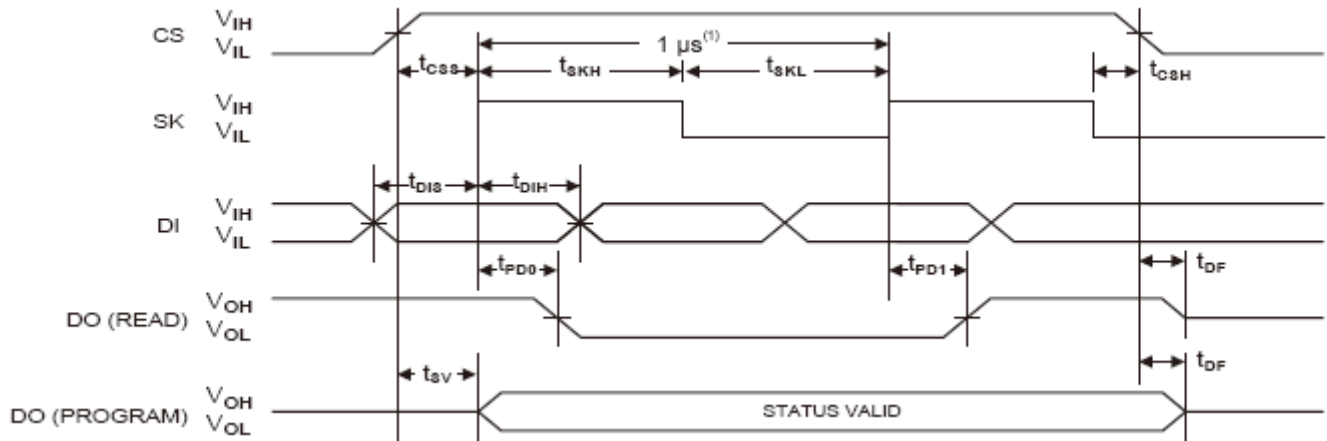
Note: This is the minimum SK period.

Figure 1: Synchronous Data Timing

Organization Key for Timing Diagrams

I/O	ACE93C46 (1K)	
	*16	*8
AN	A5	A6
DN	D15	D7

Figure 2: Read Timing

ACE93C46
Three-wire Serial EEPROM

ACE **Technology**
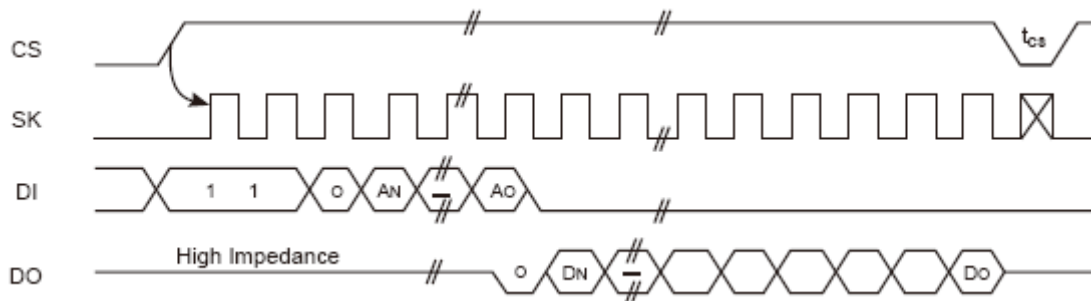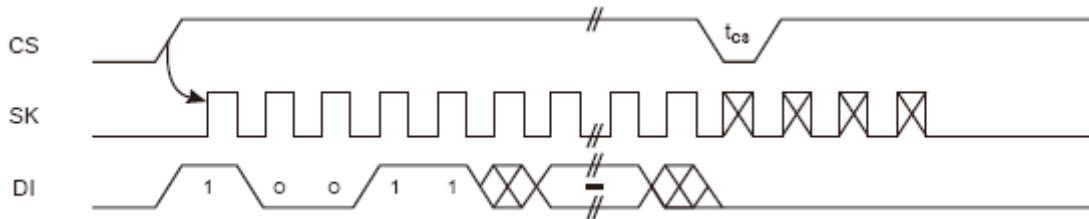
Figure 3: EWEN Timing
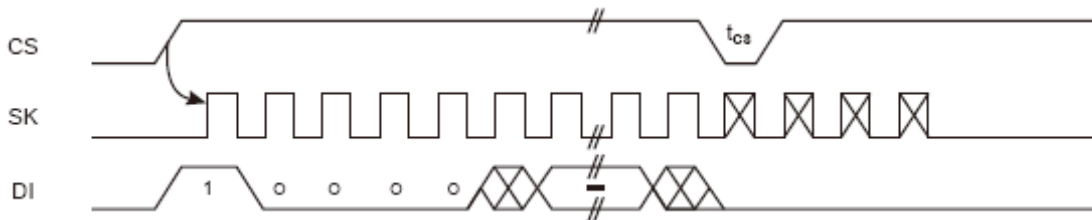
Figure 4: EWDS Timing
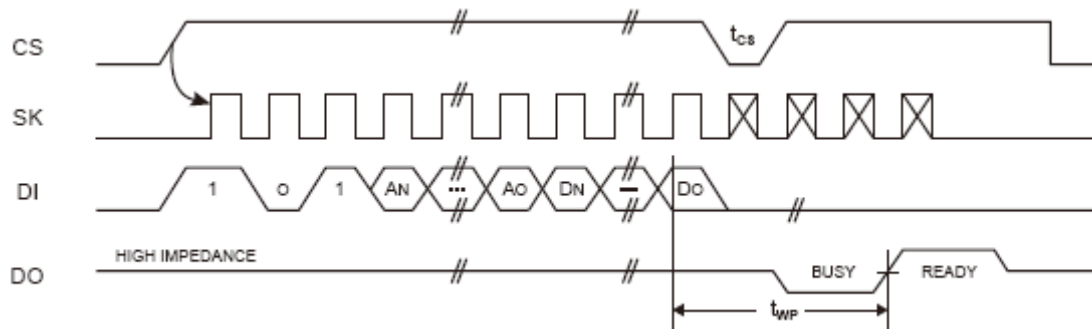
Figure 5: WRITE Timing
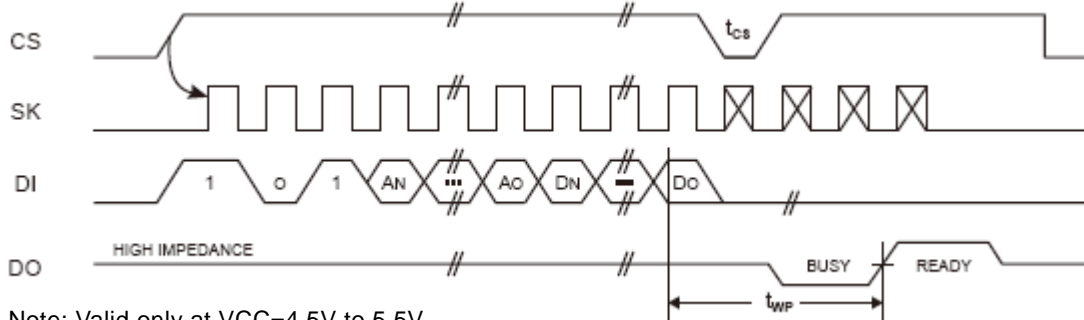
Note: Valid only at VCC=4.5V to 5.5V

Figure 6: WRAL Timing (1)

ACE *Technology*

ACE93C46
Three-wire Serial EEPROM
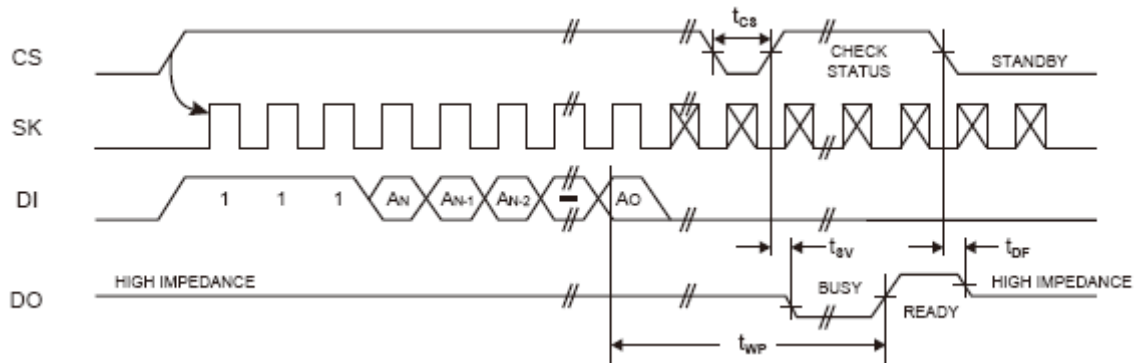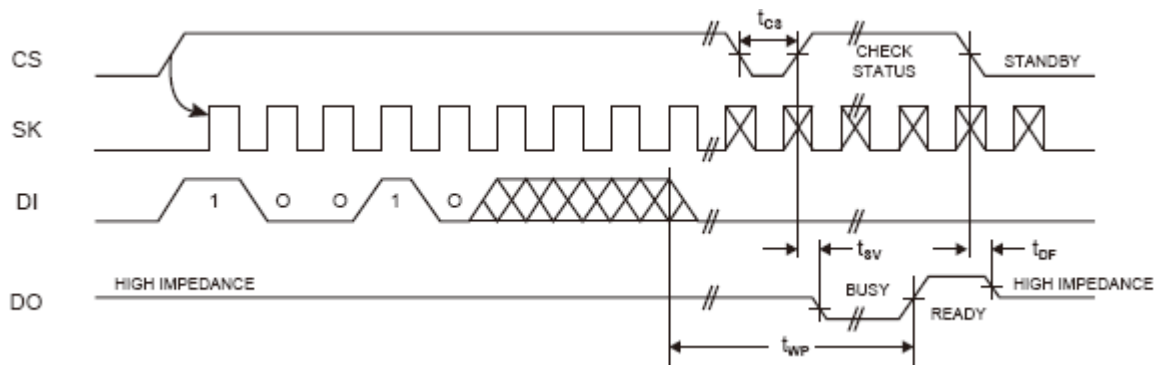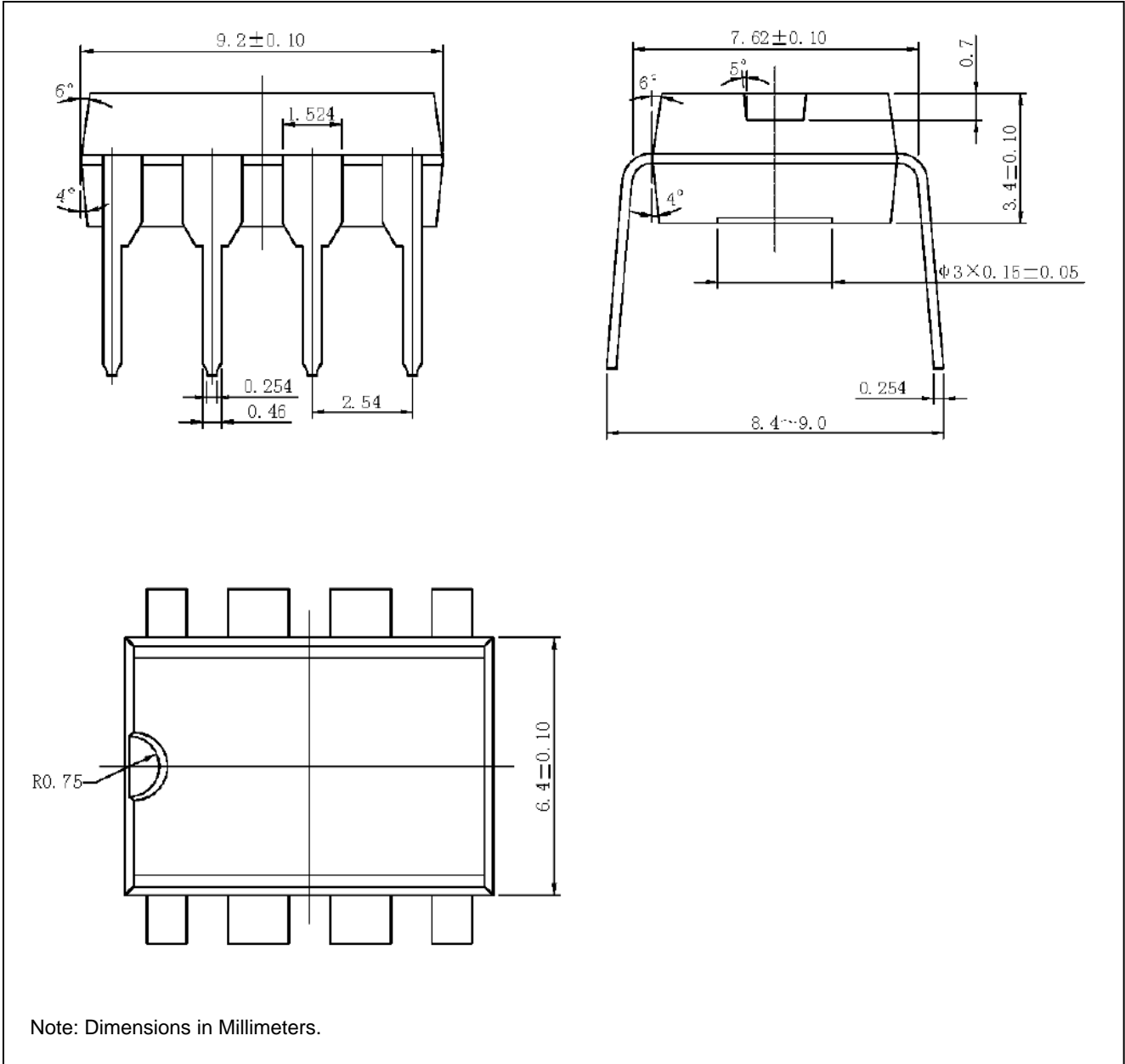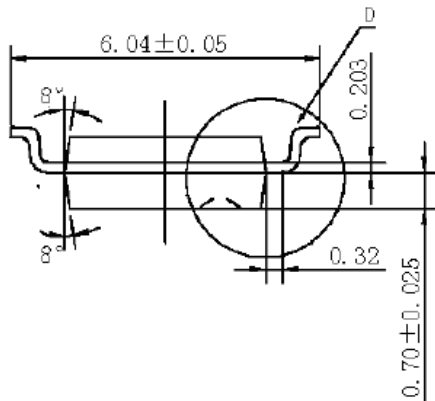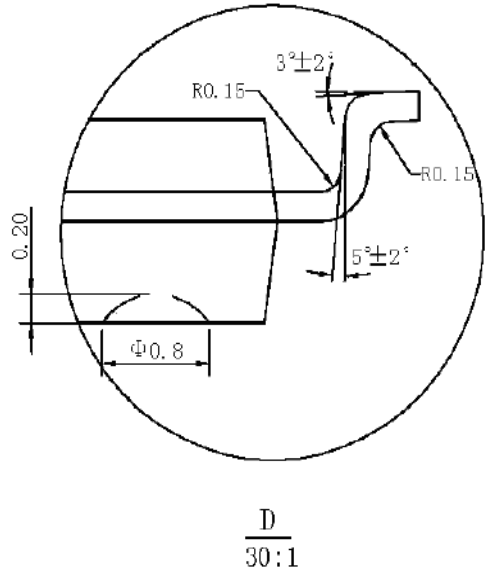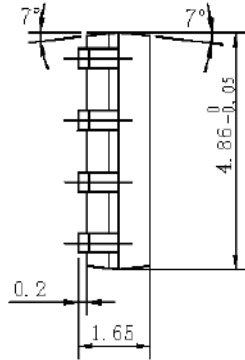
Figure 7: ERASE Timing

Note: Valid only at VCC=4.5V to 5.5V

Figure 8: ERAL Timing (1)

ACE *Technology*

Packaging information

PDIP-8

Note: Dimensions in Millimeters.

ACE *Technology*

SOP-8

Note: Dimensions in Millimeters.

VER 1.2   11

TSSOP-8

Note: Dimensions in Millimeters.

ACE *Technology*

ACE93C46
Three-wire Serial EEPROM
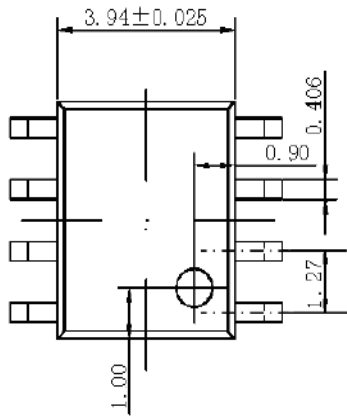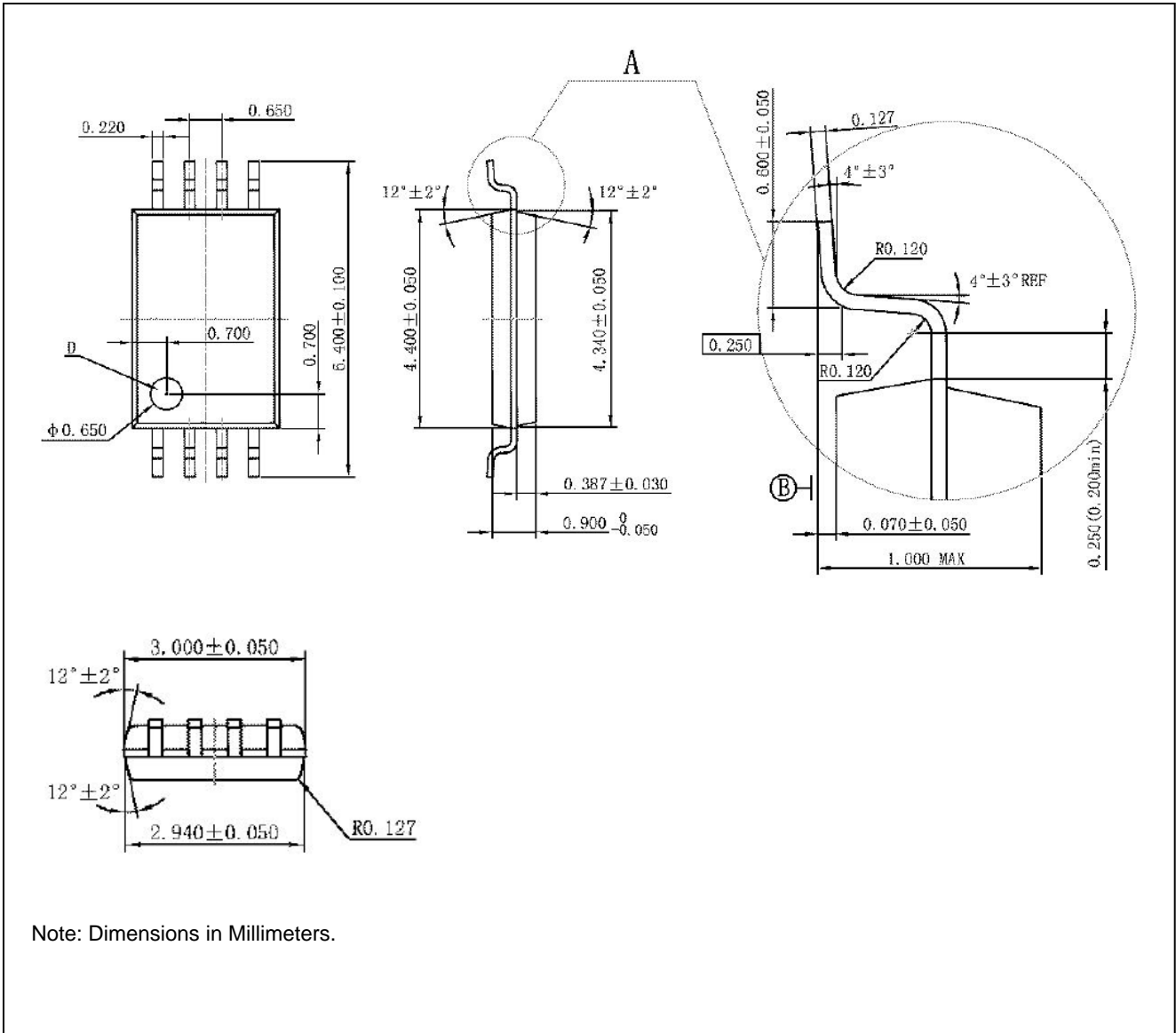
Notes

ACE does not assume any responsibility for use as critical components in life support devices or systems without the express written approval of the president and general counsel of ACE Electronics Co., LTD. As sued herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and shoes failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.

2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

ACE Technology Co., LTD.
http://www.ace-ele.com/

VER 1.2   13